

# **Notice of References Cited**

Application/Control No.

10/734,008

Applicant(s)/Patent Under  
Reexamination  
BUNCH ET AL.

Examiner

John L. Goff

Art Unit

1733

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 60221476-A	11-1985	Japan	ASAMI et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Derwent Abstract for JP 60221476 1985 <i>4w</i>			
	V	JPO Abstract for JP 60221476 1985 <i>4w</i>			
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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